

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/533,888	KAWASE ET AL.
	Examiner	Art Unit
	Binh X. Tran	1792

**SEARCHED**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
252	79.1	10/7/2008	BT
252	79.4	10/7/2008	BT
252	79.5	10/07/2008	BT
	438/692 438/693	10/7/2008	BT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**